March 1999

FAIRCHILD SEMICONDUCTOR

FDR838P P-Channel 2.5V Specified PowerTrench[™] MOSFET

General Description

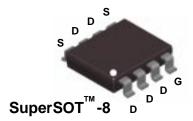
These P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

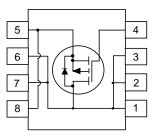
Applications

- Load switch
- Motor driving
- Power Management

Features

- Low gate charge (30nC typical).
- Fast switching speed.
- High performance trench technology for extremely low R_{DS(ON)}.
- Small footprint (38% smaller than a standard SO-8); low profile package (1 mm thick); power handling capability similar to SO-8.





Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		<u>+</u> 8	V
l _D	Drain Current - Continuous	(Note 1a)	-8	А
	- Pulsed		-50	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.8	W
		(Note 1b)	1.0	
		(Note 1c)	0.9	
T _J , T _{stg}	Operating and Storage Junction Temperature Range		-55 to +150	۰C

Thermal Characteristics

$R_{\theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	70	°C/W
R _θ JC	Thermal Resistance, Junction-to-Case	(Note 1)	20	°C/W

Package Outlines and Ordering Information

Device Marking	Device	Reel Size	Tape Width	Quantity
_838P	FDR838P	13"	12mm	3000 units

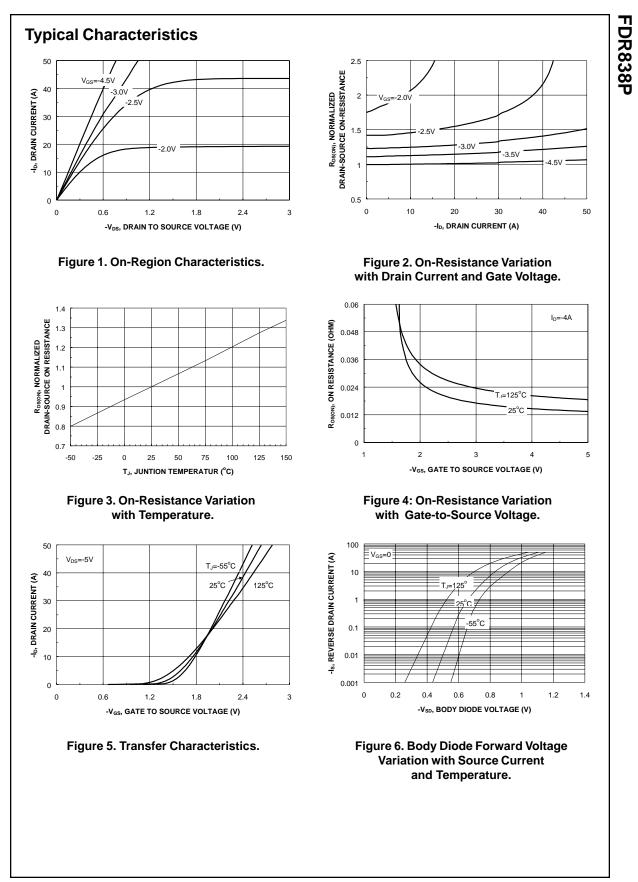
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Electrical Characteristics $T_A = 25^{\circ}C$ unless otherwise noted Symbol Min Max Units Parameter **Test Conditions** Typ **Off Characteristics** Drain-Source Breakdown Voltage $V_{GS} = 0 \text{ V}, I_D = -250 \mu \text{A}$ V -20 **BV**_{DSS} I_D = -250 μ A, Referenced to 25°C mV/∘C Breakdown Voltage Temperature -18 Coefficient ΔT_J $V_{\text{DS}} = -16 \text{ V}, \text{ } V_{\text{GS}} = 0 \text{ V}$ Zero Gate Voltage Drain Current -1 μΑ IDSS Gate-Body Leakage Current, Forward $V_{\text{GS}}=8~\text{V},~V_{\text{DS}}=0~\text{V}$ 100 nA I_{GSSF} $V_{GS} = -8 V, V_{DS} = 0 V$ Gate-Body Leakage Current, Reverse -100 nA I_{GSSR} On Characteristics (Note 2) Gate Threshold Voltage $V_{DS} = V_{GS}, I_D = -250 \ \mu A$ -0.4 -0.85 -1.5 V V_{GS(th)} I_{D} = -250 μ A, Referenced to 25°C mV/∘C AVGS(th)Gate Threshold Voltage 3 **Temperature Coefficient** ΔT_{J} $V_{GS} = -4.5 \text{ V}, I_{D} = -8 \text{ A}$ $R_{\text{DS(on)}}$ Static Drain-Source 0.014 0.017 Ω **On-Resistance** V_{GS} = -4.5V, I_D = -8 A, T_J=125°C 0.020 0.026 $V_{GS} = -2.5 \text{ V}, I_D = -7.0 \text{ A}$ 0.020 0.024 **On-State Drain Current** $V_{GS} = -4.5 V, V_{DS} = -5 V$ -50 А I_{D(on)} **g**_{FS} Forward Transconductance $V_{\text{DS}} = \textbf{-5} \ V, \ I_{\text{D}} = \textbf{-8} \ A$ 28 S **Dynamic Characteristics** Input Capacitance $V_{DS} = -10 V, V_{GS} = 0 V,$ 3300 pF Ciss f = 1.0 MHz **Output Capacitance** C_{oss} 730 pF pF Crss **Reverse Transfer Capacitance** 350 Switching Characteristics (Note 2) $V_{DD} = -10 V$, $I_{D} = -1 A$, Turn-On Delay Time 14 25 ns t_{d(on)} V_{GS} = -4.5 V, R_{GEN} = 6 Ω Turn-On Rise Time 20 32 ns tr Turn-Off Delay Time 150 110 t_{d(off)} ns Turn-Off Fall Time 60 90 tf ns $V_{DS} = -10 V$, $I_{D} = -8 A$, Qq **Total Gate Charge** 30 45 nC $V_{GS} = -4.5 V$ Gate-Source Charge 5 nC Q_{gs} Gate-Drain Charge 9 nC Q_{qd} **Drain-Source Diode Characteristics and Maximum Ratings** Maximum Continuous Drain-Source Diode Forward Current -1.5 A ls Drain-Source Diode Forward Voltage $V_{GS} = 0 V$, $I_S = -1.5 A$ (Note 2) -0.7 -1.2 V V_{SD} 1. ReJA is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain Pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design. a) 70° C/W when mounted on a ЛЦ b) 125° C/W when mounted on c) 135° C/W when mounted on 1.0 in² pad of 2 oz. copper. a 0.026 in² pad of 2oz. copper. a minimum pad.

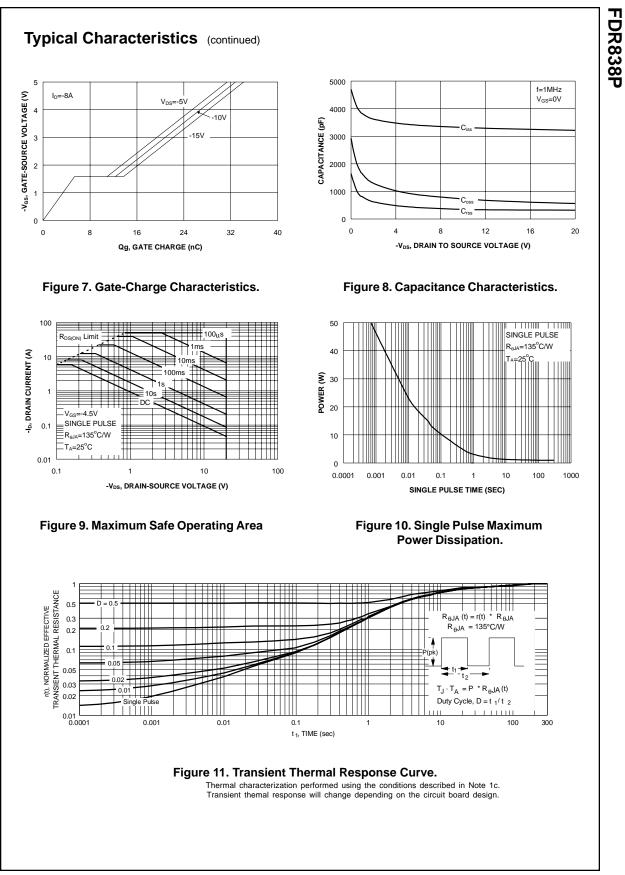
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width $\leq 300~\mu\text{s},~\text{Duty}~\text{Cycle} \leq 2.0\%$

FDR838P



FDR838P, Rev. C



FDR838P, Rev. C

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